

Title (en)
SILICON NITRIDE BASED SINTERED COMPACT AND METHOD FOR PRODUCTION THEREOF, AND MEMBER FOR MOLTEN METAL, MEMBER FOR HOT WORKING AND MEMBER FOR EXCAVATION

Title (de)
SINTERKÖRPER AUF SILICIUMNITRIDBASIS UND HERSTELLUNGSVERFAHREN DAFÜR UND ELEMENT FÜR SCHMELZFLÜSSIGES METALL, ELEMENT ZUR WARMFORMGEBUNG UND ELEMENT ZUM AUSSCHACHTEN

Title (fr)
PIÈCE FRITTÉE À BASE DE NITRURE DE SILICIUM ET SON PROCÉDÉ DE FABRICATION, ÉLÉMENT DE MÉTAL EN FUSION, ÉLÉMENT DE FORMAGE À CHAUD ET ÉLÉMENT D'EXCAVATION

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Application
EP 05809532 A 20051122

Priority
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• JP 2004342338 A 20041126

Abstract (en)
A silicon nitride sintered body comprising 2 -sialon expressed by a composition formula of $\text{Si } 6 - z \text{ Al } z \text{ O } z \text{ N } 8 - z$, wherein z value being the dissolved amount is 0.1 to 1, as a main phase, a grain boundary phase and Fe silicide particles. The grain boundary phase contains RE (Group III elements in the periodic table)-Al-Si-O, and component ratios of Al, Si and RE in terms of $\text{Al } 2 \text{ O } 3$, $\text{SiO } 2$, RE $2 \text{ O } 3$, respectively is 5 to 50 mass % of $\text{Al } 2 \text{ O } 3$, 5 to 20 mass % of $\text{SiO } 2$, and the balanced amount of RE $2 \text{ O } 3$, the grain boundary phase is contained in a range of 20 volume % or less to 100 volume % of the sintered body, and the Fe silicide particles is contained in 0.02 to 3 mass % in terms of Fe to 100 mass % of the sintered body. Its high thermal shock resistance provides suitable applications to members for molten metal, hot working, and digging.

IPC 8 full level
C04B 35/599 (2006.01)

CPC (source: EP US)
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